

APPROVAL SHEET

WLBD2012HC High Current Chip Bead

*Contents in this sheet are subject to change without prior notice.



FEATURES

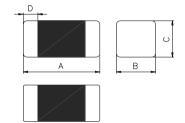
- 1. Closed magnetic circuit.
- 2. High current

APPLICATIONS

1. Noise reduction for general signal and DC line for General electronic circuits. Ex:PCs \ Networking and Consumer electronics.

SHAPE and DIMENSION





Chip Size				
Α	2.00±0.20			
В	1.25±0.20			
С	0.85±0.20			
D	0.50±0.30			

Units: mm

Ordering Information

WL	BD	2012	НС	U	300	Т	В
Product Code	Series	Dimensions	Series extension	Tolerance	Value	Packing Code	
WL: Inductor	BD :Chip Bead.	2.0 * 1.2 mm 2012 :EIA 0805	HC: High Current. Refer to characteristic	U: ±25%	300 =30 OHM 301 =300 OHM	T = 7" Paper Tape	B:STD



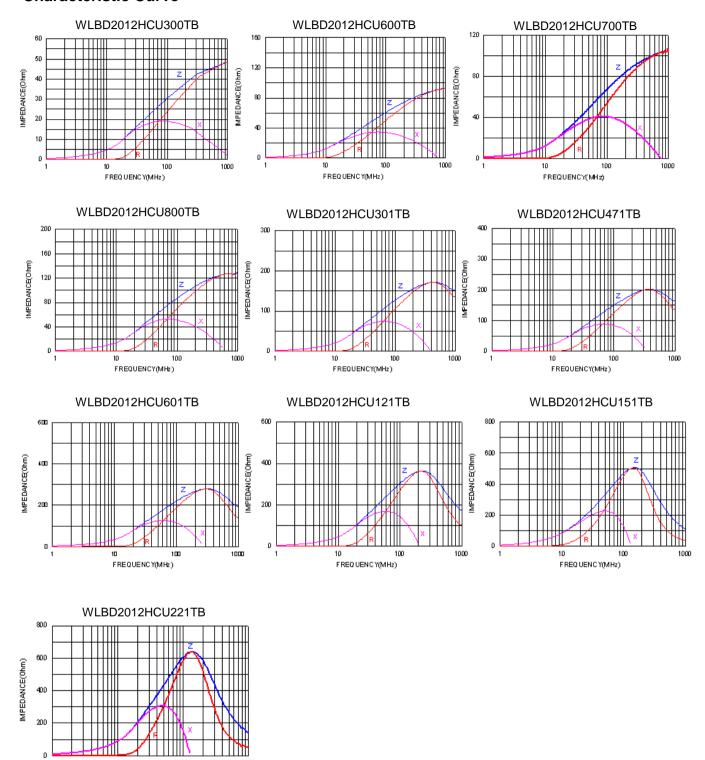
Electrical Characteristics

WLBD2012HC series

Walsin Part Number	Impedance (Ω)	Test Frequency (MHz)	DC Resistance (Ω) max.	Rated Current (mA) max.
WLBD2012HCU300TB	30±25%	100	0.04	3000
WLBD2012HCU600TB	60±25%	100	0.04	3000
WLBD2012HCU700TB	70±25%	100	0.04	3000
WLBD2012HCU800TB	80±25%	100	0.04	3000
WLBD2012HCU121TB	120±25%	100	0.10	2000
WLBD2012HCU151TB	150±25%	100	0.10	2000
WLBD2012HCU221TB	220±25%	100	0.10	2000
WLBD2012HCU301TB	300±25%	100	0.20	1000
WLBD2012HCU471TB	470±25%	100	0.20	1000
WLBD2012HCU601TB	600±25%	100	0.20	1000



Characteristic Curve



FREQUENCY(MHz)



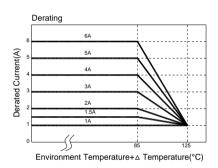
Test condition & Requirements

Item	Performance	Test Condition				
Operating Temperature	-40~+125℃ (Including self-temperature rise)					
Transportation Storage Temperature	-40~+125℃ (on board)	For long storage conditions, please see Application Notice				see the
Impedance (Z)		Agilent42	91			
Inductance (Ls)		Agilent E	4991			
Q Factor		Agilent4287 Agilent16192				
	Refer to standard electrical characteristics list					
DC Resistance		Agilent 43	Agilent 4338			
Rated Current		DC Powe Over Rat be some	ted Cu		uirements, t	there will
Temperature Rise Test	Rated Current < 1A ΔT 20 $^{\circ}$ C Max Rated Current \geq 1A ΔT 40 $^{\circ}$ C Max	2. Tempe			current. I by digital s	urface
		Number o	of heat	cycles: 1		
		Temperat (°C		Time (s)	Temperaturamp/imme	ersion
Designation to Caldering	Appearance : No damage. Impedance : within±15% of initial value	260 ±5 (solder te	emp)	10 ±1	25mm/s ±	±6 mm/s
Resistance to Soldering Heat	Impedance: within±15% of initial value Inductance: within±10% of initial value Q: Shall not exceed the specification value. RDC: within ±15% of initial value and shall not exceed the specification value		Depth: completely cover the termination			
Solderability	More than 95% of the terminal electrode should be covered with solder.	Steam Aging: 8 hours ± 15 min Preheat: 150°C,60sec. Solder: Sn96.5%-Ag3%-Cu0.5% Solder temperature: 245±5°C Flux for lead free: Rosin. 9.5% Dip time: 4±1sec. Depth: completely cover the termination			on	
Terminal strength	Appearance: No damage. Impedance: within±15% of initial value Inductance: within±10% of initial value Q: Shall not exceed the specification value. RDC: within±15% of initial value and shall not exceed the specification value	Preconditioning: Run through IR reflow for times.(IPC/JEDEC J-STD-020D Classificatic Reflow Profiles) Component mounted on a PCB apply a for (>0.55:1kg <=0.805:0.5kg)to the side of device being tested. This force shall be applied for 60 +1 seconds. Also the force shall be applied gradually as not to shock the component being tested.			sification y a force ide of a shall be the force	
Bending	Appearance: No damage. Impedance: within±10% of initial value Inductance: within±10% of initial value Q: Shall not exceed the specification value. RDC: within ±15% of initial value and shall not exceed the specification value	Shall be mounted on a FR4 substrate of the following dimensions:>=0805:40x100x1.2mm <0805:40x100x0.8mm Bending depth:>=0805:1.2mm <0805:0.8mm Duration of 10 sec for a min.			x1.2mm	
Vibration Test	Appearance: No damage. Impedance: within±15% of initial value Inductance: within±10% of initial value Q: Shall not exceed the specification value. RDC: within ±15% of initial value and shall not exceed the specification value	Preconditioning: Run through IR reflow for times.(IPC/JEDEC J-STD-020D Classificatio Reflow Profiles) Oscillation Frequency: 10~2K~10Hz for 2 minutes Equipment: Vibration checker Total Amplitude:1.52mm±10% Testing Time: 12 hours(20 minutes, 12 cycle each of 3 orientations)			sification	
	Appearance: No damage. Impedance: within±10% of initial value Inductance: within±10% of initial value		ndition	:		
Shock	Impedance: within±10% of initial value	Type	Peak Value (g's)	Normal duration (D) (ms)	Wave form Half-sine	Velocity change (Vi)ft/sec 11.3

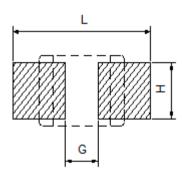
Item	Performance	Test Condition
Life test	Appearance: no damage. Impedance: within±15%of initial value.	Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020D Classification Reflow Profiles) Temperature: 125±2°C (bead), 105±2°C (Inductor) Applied current: rated current. Duration: 1000±12hrs. Measured at room temperature after placing for 24±2 hrs.
Load Humidity	Inductance: within±10%of initial value. Q: Shall not exceed the specification value. RDC: within ±15% of initial value and shall not exceed the specification value	Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020D Classification Reflow Profiles) Humidity: 85±2%R.H. Temperature: 85±2℃. Duration: 1000hrs Min. with 100% rated current. Measured at room temperature after placing for 24±2 hrs.
Thermal shock	Appearance: no damage. Impedance: within±15%of initial value. Inductance: within±10%of initial value. Q: Shall not exceed the specification value. RDC: within ±15% of initial value and shall not exceed the specification value	Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020D Classification Reflow Profiles) Condition for 1 cycle Step1: $-40\pm2^{\circ}\mathbb{C}$ 30 ± 5 min. Step2: $25\pm2^{\circ}\mathbb{C}$ ≤0.5 min Step3: $+125\pm2^{\circ}\mathbb{C}$ 30 ± 5 min. (Bead) Step3: $+105\pm2^{\circ}\mathbb{C}$ 30 ± 5 min. (Inductor) Number of cycles: 500 Measured at room temperature after placing for 24 ± 2 hrs.

**Derating Curve

For the ferrite chip bead which withstanding current over 1.5A, as the operating temperature over $85^{\circ}\mathrm{C}$, the derating current information is necessary to consider with. For the detail derating of current, please refer to the Derated Current vs. Operating Temperature curve.



Soldering and Mounting



	L (mm)	G (mm)	H (mm)
WLBD2012HC	3.00	1.00	1.00



Soldering

Mildly activated rosin fluxes are preferred. The terminations are suitable for re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.

If wave soldering is used ,there will be some risk.

Re-flow soldering temperatures below 240 degrees, there will be non-wetting risk

Lead Free Solder re-flow

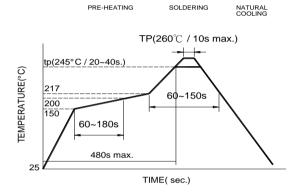
Recommended temperature profiles for lead free re-flow soldering in Figure 1. (Refered to J-STD-020C)

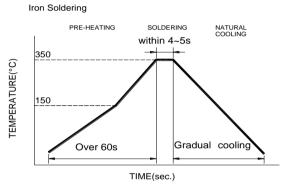
Soldering Iron:

Products attachment with a soldering iron is discouraged due to the inherent process control limitations. If a soldering iron must be employed the following precautions are recommended. for Iron Soldering in Figure 2.

- Preheat circuit and products to 150°C
- · Never contact the ceramic with the iron tip
- 350°C tip temperature (max)
- Use a 20 watt soldering iron with tip diameter of 1.0mm
- · 1.0mm tip diameter (max)
- · Limit soldering time to 4~5sec.

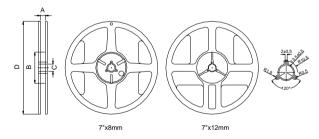






Packaging Specification

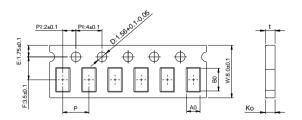
Reel Dimension



Туре	A(mm)	B(mm)	C(mm)	D(mm)	
7"x8mm	9.0±0.5	60±2	13.5±0.5	178±2	
7"x12mm	13.5±0.5	60±2	13.5±0.5	178±2	

Tape Dimension / 8mm

■Material of taping is paper



Size	Bo(mm)	Ao(mm)	Ko(mm)	P(mm)	t(mm)
WLBD2012HC	2.10±0.05	1.30±0.05	0.95±0.05	4.0±0.10	0.95±0.05